

Application/Control No.	Applicant(s)/Patent under Reexamination

REID, LAURA Art Unit

10/653,670 Examiner

Quynh H. Nguyen

2642

SEARCHED				
Class	Subclass	Date	Examiner	
379	33 37 93.01 93.07 106.01 221.01	6/28/2005	QN	
379	221.02	6/28/2005	QN	
379	221.03	6/28/2005	QN	
379	221.14	6/28/2005	QN	
379	207.14	6/28/2005	QN	
379	211.01	6/28/2005	QN	
379	211.02	6/28/2005	QN	
379	212.01	6/28/2005	QN	
370	351 352 353 354 355 356	6/28/2005	QN	
above	updated	1/19/06	QN	

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NO (INCLUDING SEARCH	TES STRATEGY)
	DATE	EXMR
searched: east	6/28/2005	QN
Inventor searched through PALM database	6/28/05	QN